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| <b>INFORMATION DISCLOSURE<br/>STATEMENT BY APPLICANT</b><br><br>(use as many sheets as necessary) |   |    | Application Number   | 10/091,002                  |                 |
|   |   |    | Filing Date          | March 5, 2002               |                 |
|   |   |    | First Named Inventor | Charles D. Brandle, Jr.     |                 |
|   |   |    | Art Unit             | N/A- 1765                   |                 |
|   |   |    | Examiner Name        | Not Yet Assigned- H. J. Hew |                 |
| Sheet   | 1 | of | 1                    | Attorney Docket Number      | T8060.0007/P007 |

| U.S. PATENT DOCUMENTS |                       |   |                                |  |  |
|-----------------------|-----------------------|---|--------------------------------|--|--|
| Examiner Initials*    | Cite No. <sup>1</sup> | Document Number<br>Number-Kind Code <sup>2</sup> (if known) | Publication Date<br>MM-DD-YYYY | Name of Patentee or Applicant<br>of Cited Document | Pages, Columns, Lines,<br>Where Relevant<br>Passages or Relevant<br>Figures Appear |
| F.H.                  | AA                    | 5,801,875   | 09-01-1998                     | Brandle, Jr. et al.                                |  |

| FOREIGN PATENT DOCUMENTS |                       |  |                                |  |  |                |
|--------------------------|-----------------------|--|--------------------------------|--|--|----------------|
| Examiner Initials*       | Cite No. <sup>1</sup> | Foreign Patent Document<br>Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known) | Publication Date<br>MM-DD-YYYY | Name of Patentee or<br>Applicant of Cited Document | Pages, Columns, Lines,<br>Where Relevant<br>Passages or Relevant<br>Figures Appear | T <sup>6</sup> |
|                          | AB                    |  |                                |  |  |                |

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|--------------------|---------------------------|-----------------|----------|
| Examiner Signature | <i>Michael D. Hitehew</i> | Date Considered | 11/12/03 |
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| OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS |                       |  |                |
|---|-----------------------|--|----------------|
| Examiner Initials*                                | Cite No. <sup>1</sup> | Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc), date, page(s), volume-issue number(s), publisher, city and/or country where published. | T <sup>2</sup> |
| F.H.  | AC                    | Patent Abstracts of Japan, Pub. No. 2000119100, April 25, 2000   |                |

|                    |                           |                 |          |
|--------------------|---------------------------|-----------------|----------|
| Examiner Signature | <i>Michael D. Hitehew</i> | Date Considered | 11/12/03 |
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